

U.S. Department of Commerce, Patent and Trademark Office (PTO Form 1449 modified)		Docket No. AMAT/3980/USA/MD /COPPER/DV	Serial No. 09/505,638
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT (Use several sheets if necessary)		Applicant Parkhe, et al.	Confirmation No. Unknown
Examiner Unknown		Filing Date February 16, 2000	Group 1762

U.S. Patent Documents

Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
<i>[Signature]</i>	A1	6,099,903	08-08-2000	Kaloyeros, et al.	427	250	05-19-1999
	A2						
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Foreign Patent Documents

Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
<i>[Signature]</i>	B1	EP 0 106 537	01-25-1989	EP	C23C	16/30		X
	B2	EP 1 067 595	01-10-2001	EP				X
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OTHER ART

Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
<i>[Signature]</i>	C1	Australian Patent Office Search Report from SG 200100858-0, Dated 08 October 2001.
	C2	
	C3	

Examiner

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

U.S. Department of Commerce, Patent and Trademark Office				Docket No.		Serial No.	
				AMAT/3980		UNKNOWN	
LIST OF RELEVANT ART CITED BY APPLICANT				Applicant			
(Use several sheets if necessary)				PARKHE ET AL.			
				Filing Date		Group	
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Foreign Patent Documents							Translation	
		Document Number	Date	Country	Class	Subclass	Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
	AQ	
	AR	
	AS	

Examiner	Date Considered

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